

PACE BEE
SCHEDA TECNICA
NCR Pacesetter

Ribbon cera-resina

Ottima definizione su tutti i materiali sia cartacei che sintetici. Offre in generale una buona tenuta al graffio. Resiste ad alte temperature, ideal per stampa di etichette che poi vengono poste in forni termoretrattili.

Multi-Layer Wax/ Resin composite Thermal Ribbon

Mid-Range with SPECTR TM

Performance characteristics of the NCR PaceSetter

- Unique, multi-layer construction allows for quick release and ultimate durability
- Wide latitude to a multitude of receiving materials
- Very high abrasion resistance
- Excellent edge definition
- Superior rotated bar code capability at high speeds - up to 10 IPS
- Totally static free with unique patent pending static elimination system

Recommended applications for the NCR PaceSetter

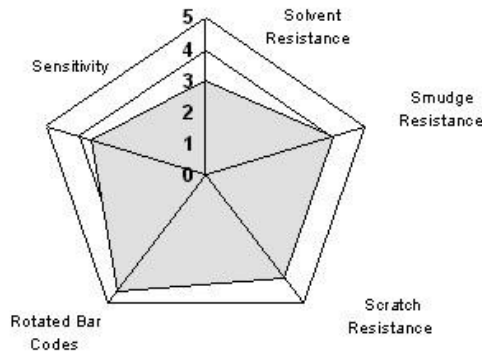
- All applications requiring moderate to high resistance to smudging and scratching
- High speed print and apply labeling systems
- Automated routing and material handling labeling
- Shipping carton and address labels
- All product ID label and tag printing; retail, industrial and apparel

Formulation Technical Information :

- Film thickness : 4.5 +/- .5 micron
- Total ribbon thickness : 7.7 +/- .3 micron
- Printing density : 1.98 Macbeth Densitometer
- Ink melting point : 80 °C / 176 ° F
- Recommended maximum print speed : 10 inches (254 mm) per second
- Recommended media substrates : Fasson Transtherm 1C, Brown-Bridge CTT, Green Bay Scan Rite CT, Fitchburg EZE Transfer TPC, Kansaki KTT-10, Kimdura, Mac Tac Optiscan, Ultrascan, Optiscan Plus and many others

Performance Diamond :

The performance diamond measures the PaceSetter thermal transfer ribbon performance characteristics when printing on targeted media substrates.



(R) Scratch test method; 1400gm, reciprocating sled with 1 /4 " ball baring (R) Smudge test method; 1400gm load, reciprocating sled 1 /4" Bumpon rubber pad (R) Print quality test method : ANSI PQS on targeted media substrates (R) High speed printing test method : ANSI PQS on targeted media substrate (R) Sensitivity test method : Atlantek thermal response test equipment.

- **NCR's** manufacturing and R&D operations are guided by and certified under **ISO 9001/9002**